

# Diagnosics for Measuring and Mitigating Femtosecond Microbunches at the LCLS

*6th Microbunching Workshop,  
6-8 October 2014, Trieste, Italy*

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Rasmus Ischebeck (PSI), Minjie Yan (DESY)

October 8, 2014

# Outline

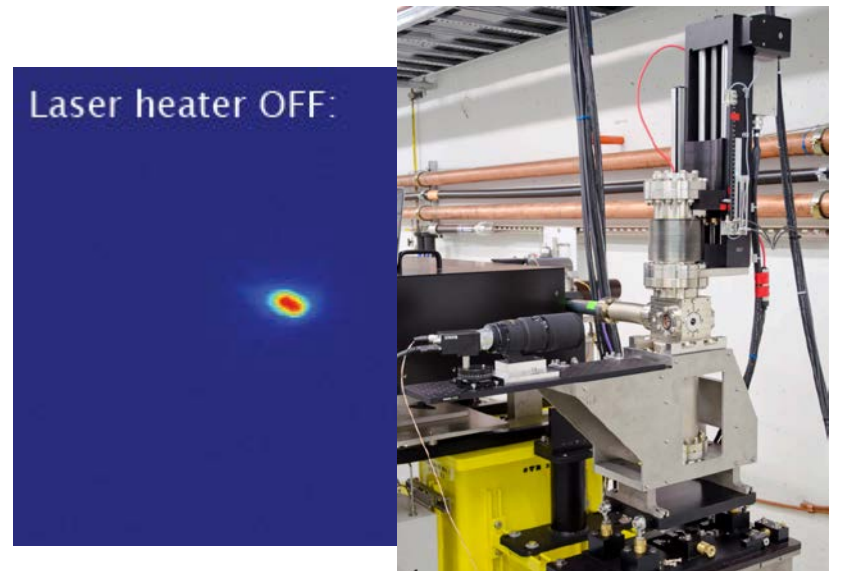
## Temporal Diagnostics:

- X-band transverse deflection structure for streaking the beam with femtosecond resolution.
- Dispersion downstream of XTCAV allows observation of full longitudinal phase space
- *Location downstream of undulator for reconstruction of x-ray emission*



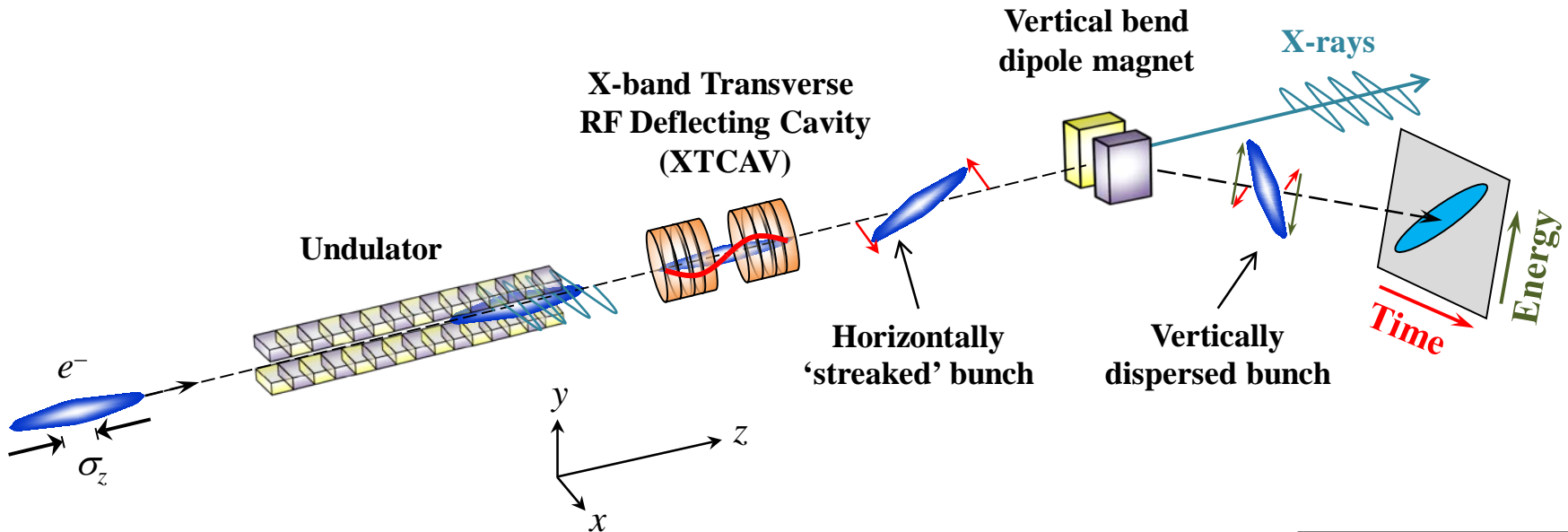
## Suppression of COTR in Profile Measurements

- SLAC test measurements with PSI profile monitor
- Sensitivity to bunch length
- Sensitivity to laser heater



# Temporal Diagnostic Measurement Layout

## XTCAV: Resolving the e-bunch $t$ - $E$ phase space



$$\sigma_t = \frac{1}{2\pi f_{\text{rf}}} \frac{E_e}{eV_{\text{rf}}} \sqrt{\frac{\epsilon_x}{\gamma\beta_x}} \propto \sqrt{E_e} \propto \frac{1}{f_{\text{rf}}}$$

Time resolution

High- $E$  FEL

x8 improvement  
with SLAC X-band  
@ 11.4 GHz

**Result:**  
1 fs rms @ SXR  
3 fs rms @ HXR



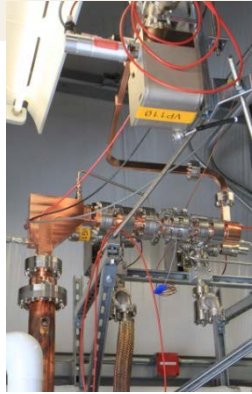
**Installation in the LCLS Undulator Hall**

# A powerful, but not inexpensive diagnostic

SLAC



50 MW  
klystron



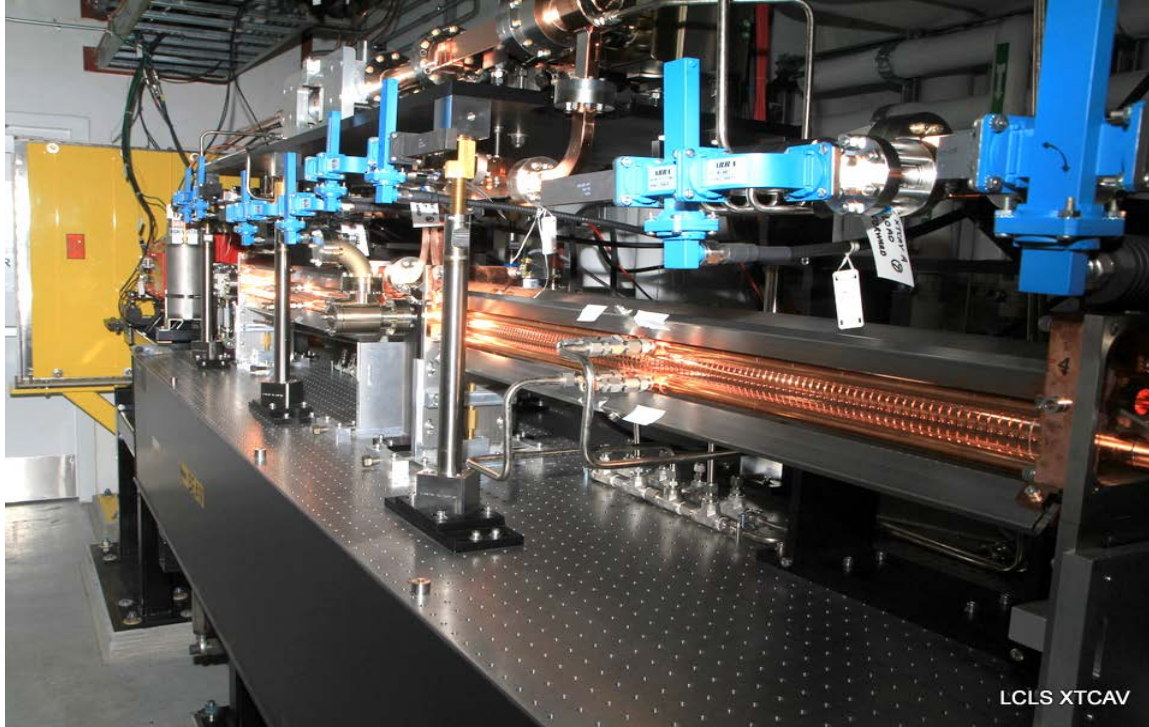
waveguide



Controls:  
PAC, PADS,



430 kV  
modulator



LCLS XTCAV



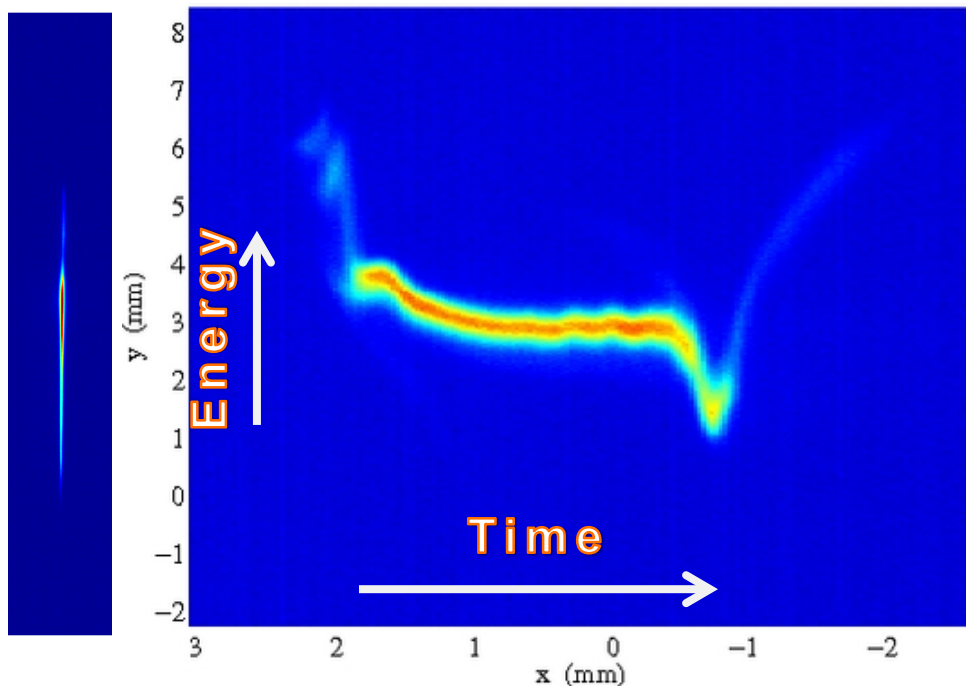
LLRF Drive:  
TWTA, klystron  
Mag. Suppl.

# Measurement examples: 4.7GeV, 150pC (1keV)

SLAC

## Three Images at the e-dump spectrometer screen

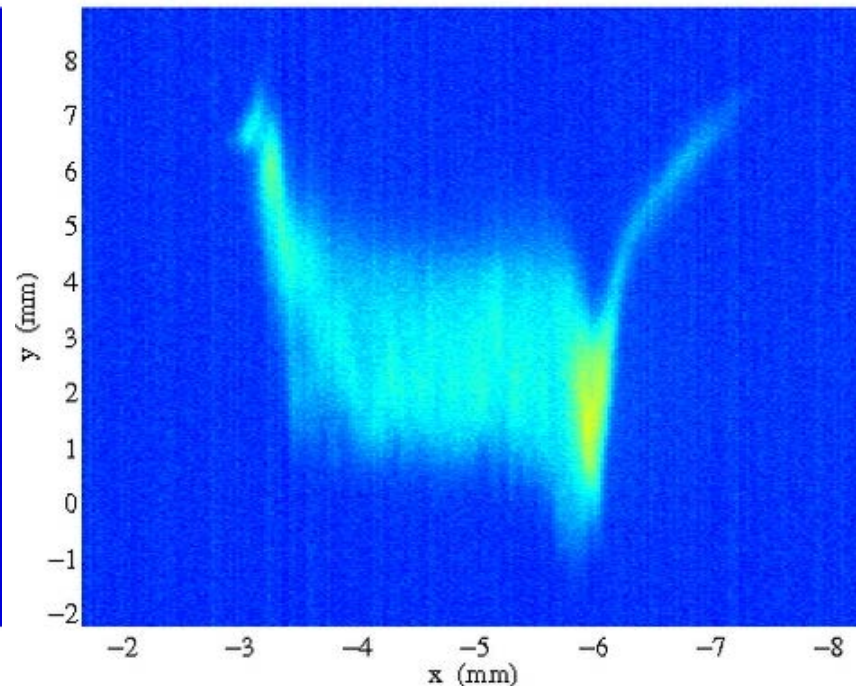
Profile Monitor OTRS:DMP1:695 23-Jul-2013 22:17:15



XTCAV  
Off

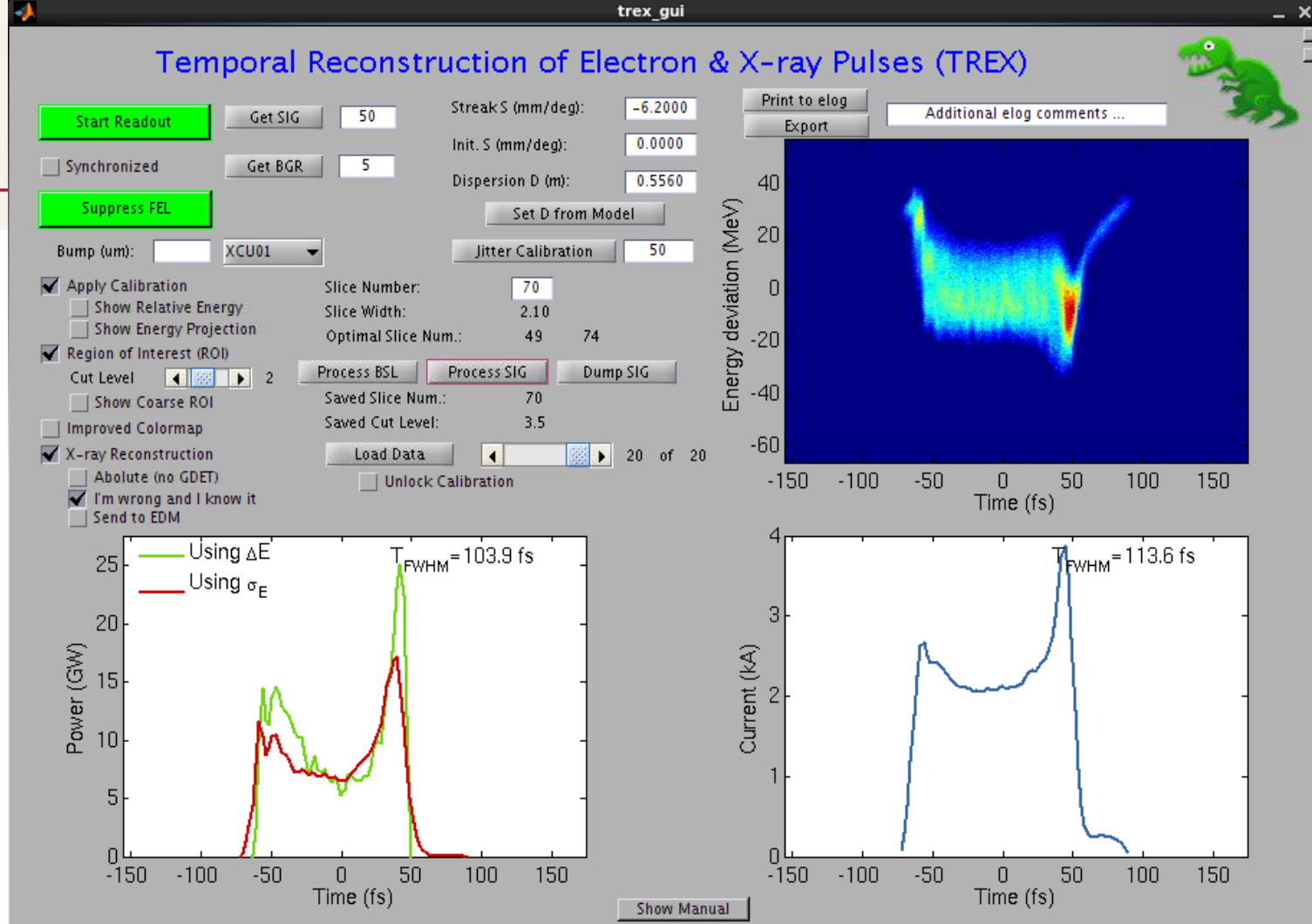
XTCAV On  
FEL Supressed  
(baseline)

Profile Monitor OTRS:DMP1:695 23-Jul-2013 22:58:15



XTCAV On  
FEL On  
~1mJ FEL pulse energy

# Real-Time data analysis



- Analyze energy difference between FEL On and FEL Off images C. Behrens et al

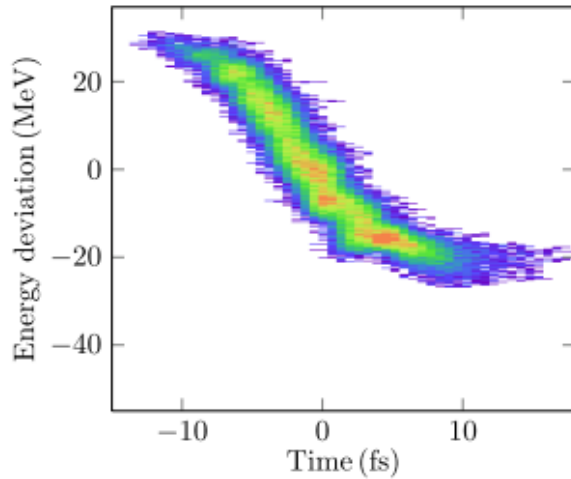
$$P_{\text{FEL}}(t) = [\langle E \rangle_{\text{FEL off}}(t) - \langle E \rangle_{\text{FEL on}}(t)] \times I(t)$$

- Alternative analysis based on change in energy spread

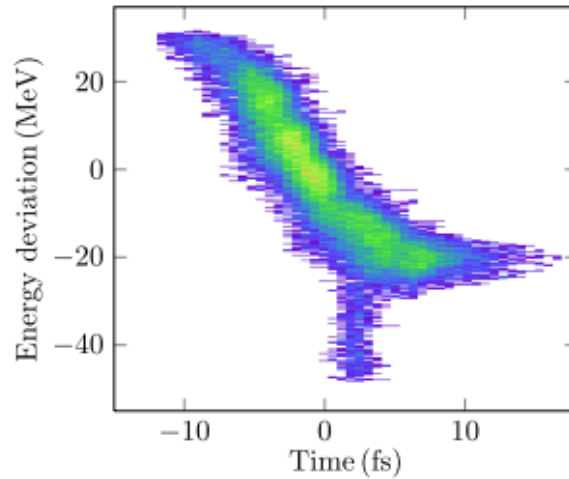
$$P_{\text{FEL}}(t) \propto [\sigma_{E,\text{FEL on}}^2(t) - \sigma_{E,\text{FEL off}}^2(t)] \times I^{2/3}(t)$$

# Able to resolve individual features

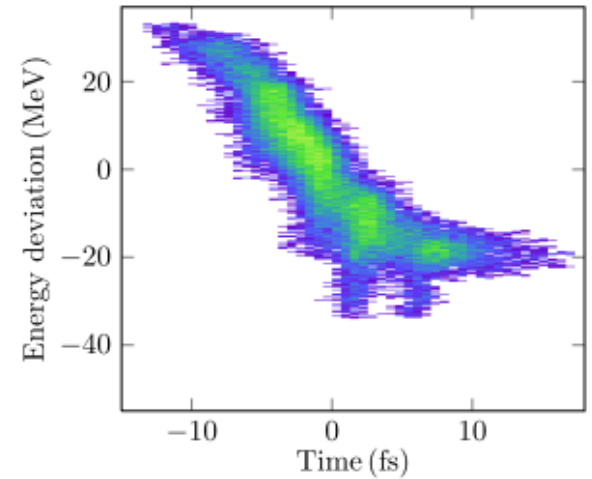
-- 20pC, 1keV examples



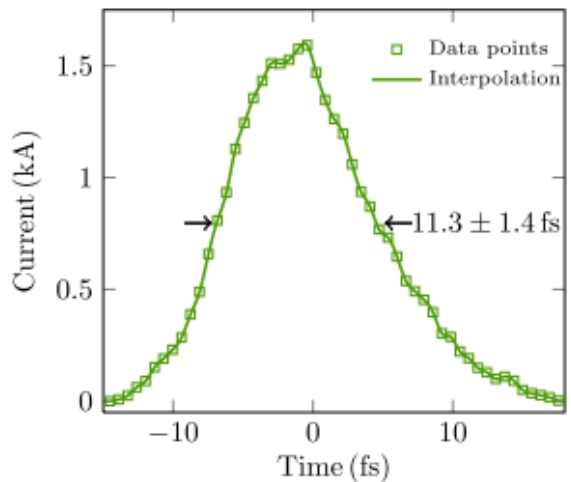
(a) Lasing off



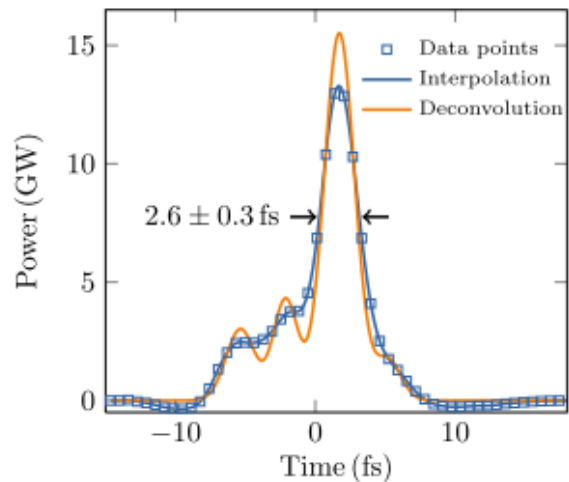
(b) Lasing on, shot 1



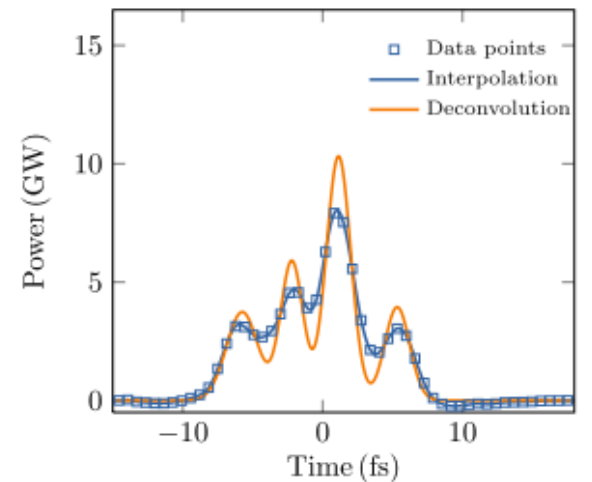
(c) Lasing on, shot 2



(d) Electron current



(e) X-ray power, shot 1



(f) X-ray power, shot 2



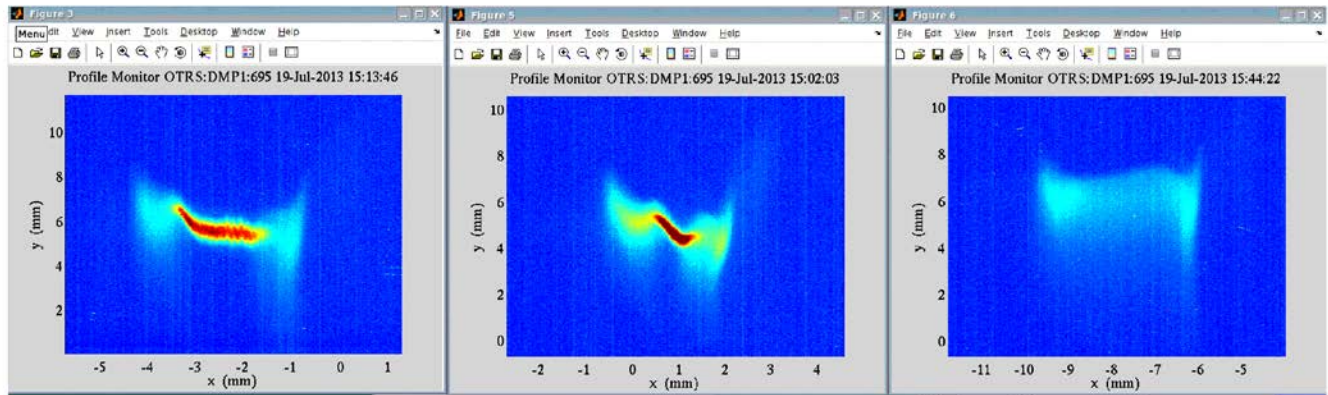
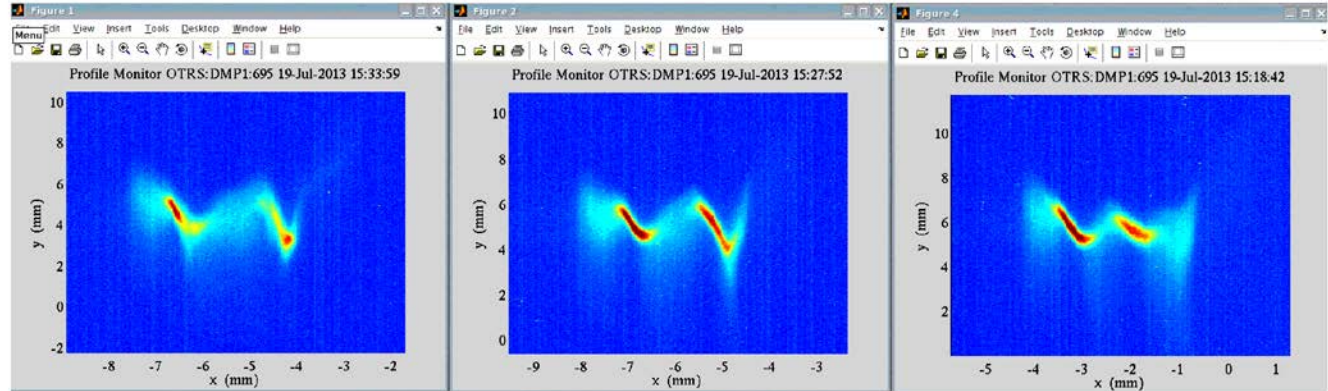
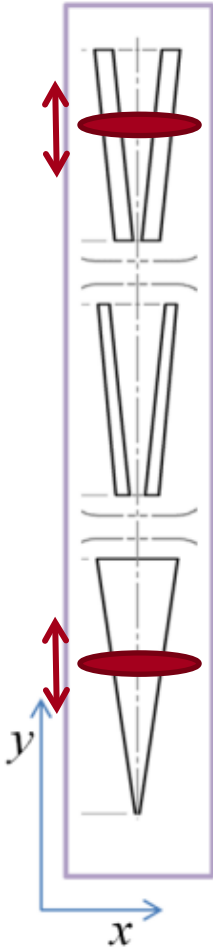
# Is it a suitable diagnostic for Microbunch Instabilities

- Previous slide demonstrated that temporal resolution is adequate
- Next question is whether features on the beam that are generated upstream in the bunch compressor are preserved all the way through to the measurement screen.
- Test this by generating temporal features using a pair of slits in the bunch compressor chicane

# Features introduced upstream at BC are preserved Slotted-foil examples (lasing off)

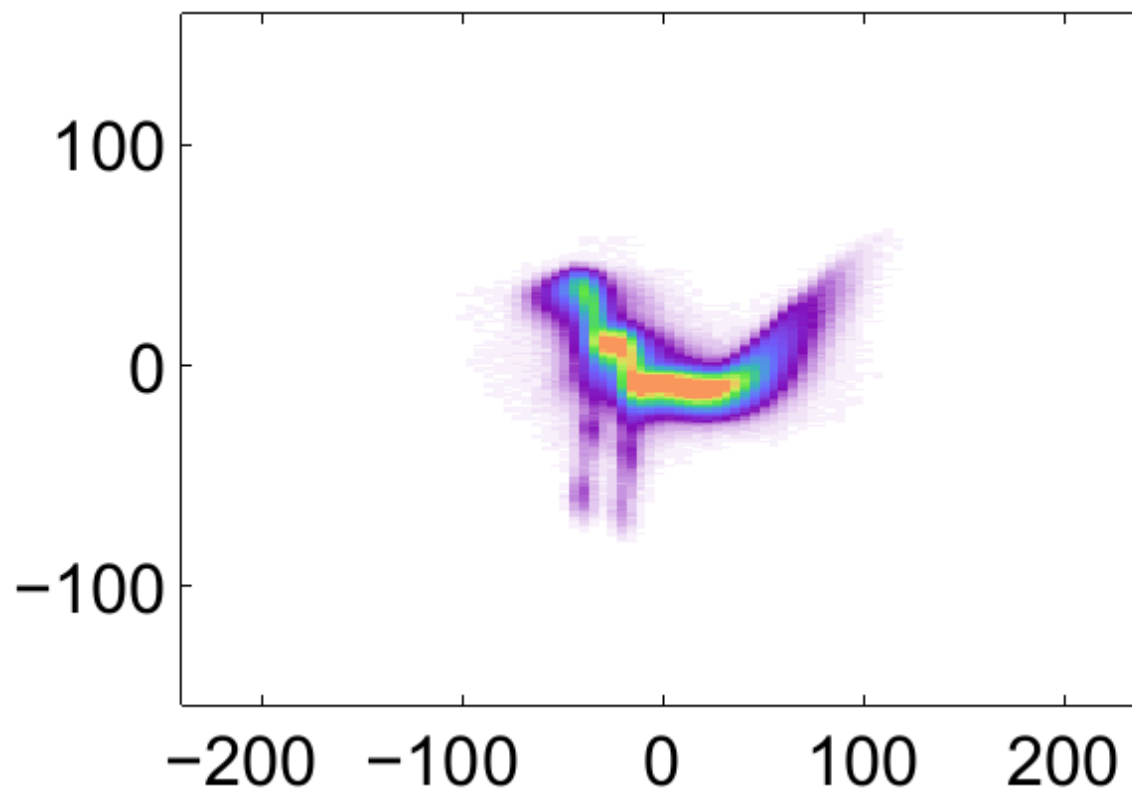
shows clearly the unspoiled beam region

Double  
Slit



4.7GeV, 150 pC

# Lasing with double-slotted foil

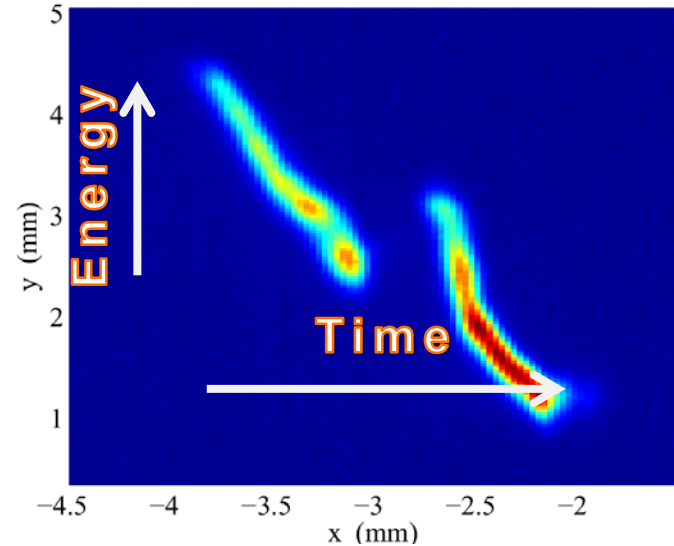


# Second example with pulse stacking

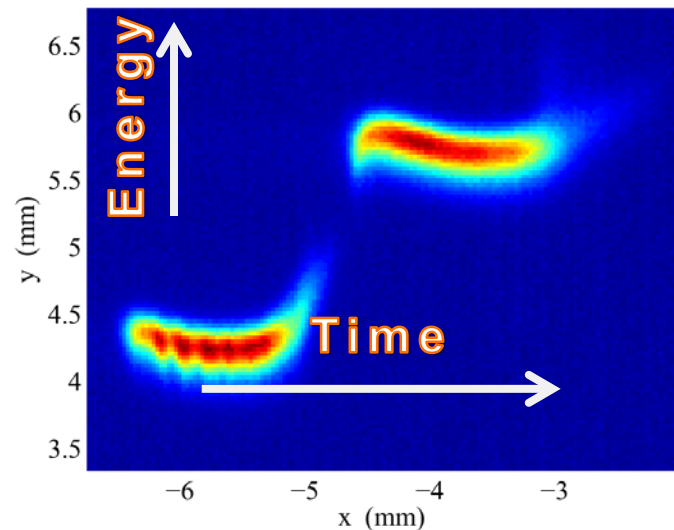
Laser pulses are stacked at the LCLS photo-Injector to produce multiple electron bunches within one RF bucket A Marinelli

XTCAV gives clear view of bunch separation and orientation in longitudinal phase space

Profile Monitor OTRS:DMP1:695 31-Jul-2013 10:50:54

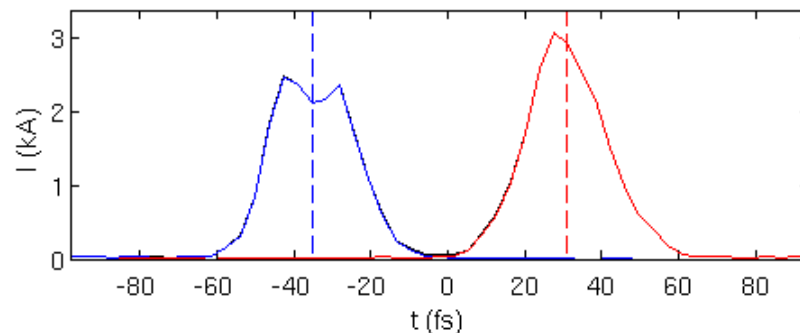
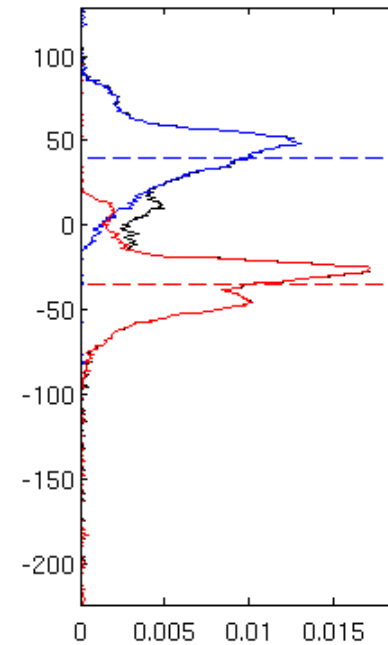
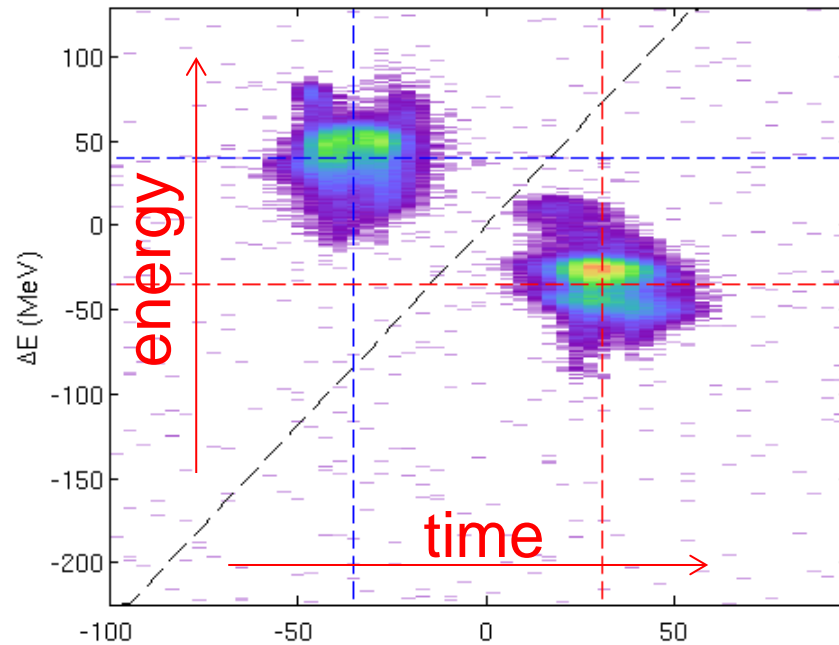


Profile Monitor OTRS:DMP1:695 31-Jul-2013 10:44:43



# Double-bunch (two-color) example - A. Marineli

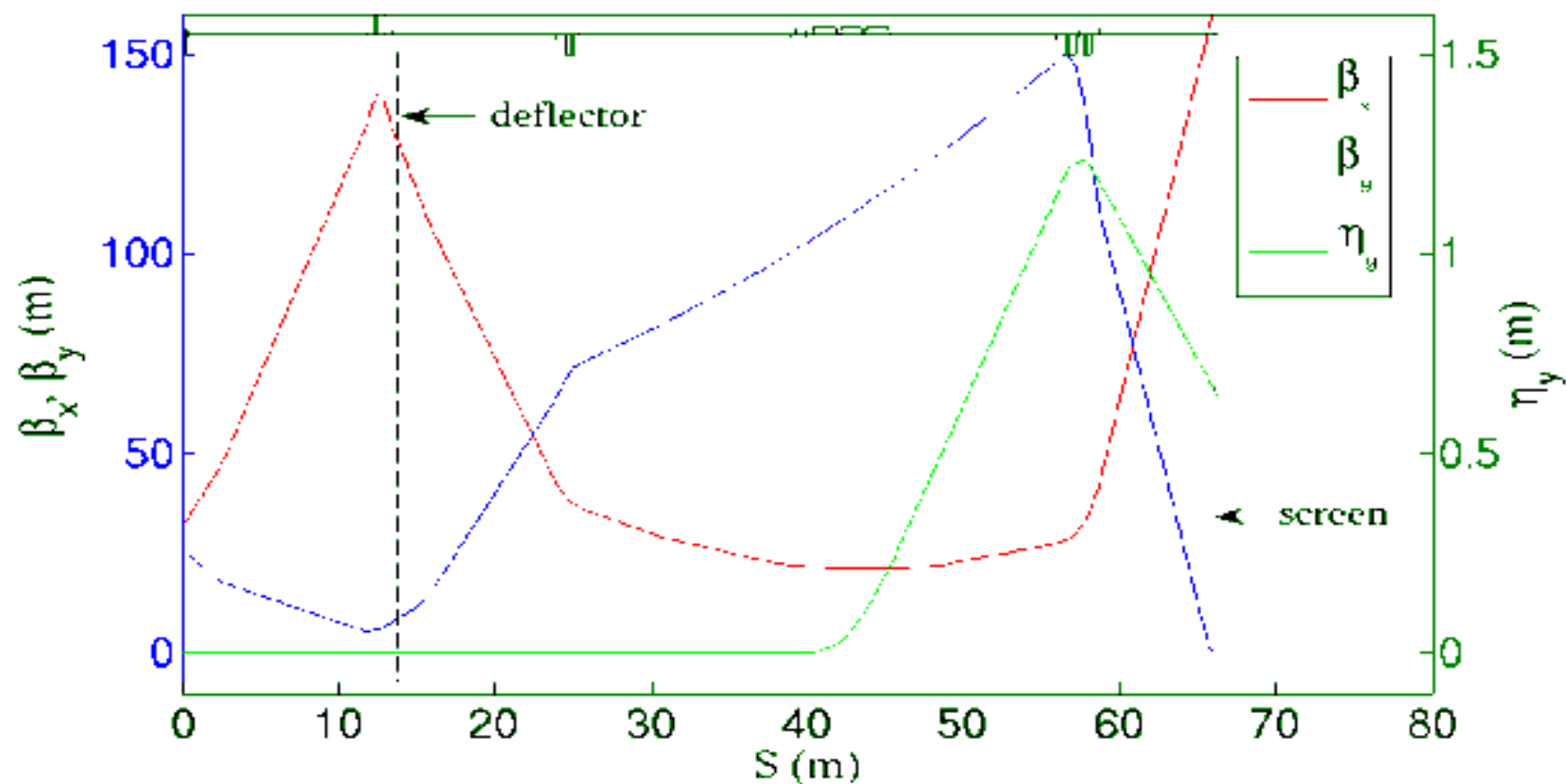
Shot #15, TREX-SIG\_Images-2014-01-21-232217.mat



	#1	#2
$Q$ (pC) =	69.3	79.1
$\langle t \rangle$ (fs) =	-35.2	30.8
$\sigma_t$ (fs) =	12	13.7
$\langle E \rangle$ (MeV) =	40.2	-35.2
$\sigma_E$ (MeV) =	24.4	28

GDET = 0.273 mJ  
 $Q_{\text{tot}}$  = 148 pC  
 $E_{\text{DL2}}$  = 13601 MeV  
 $\Delta t$  = 66 fs  
 $\Delta E$  = 75.4 MeV

# Beam Line Optics

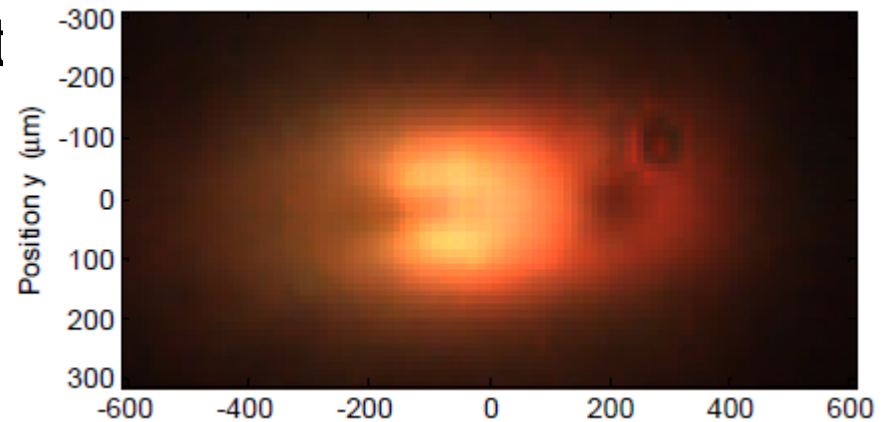


## Summary (1)

- The LCLS XTCAV system has been implemented as a powerful diagnostic tool
- Can distinguish temporal microstructures in the beam down to 1 fs resolution
- Slice energy spread can also be resolved with keV resolution
- Examples of microbunching instability shown in Tim Maxwell's talk.

## 2. Beam Profile Measurements and MBI induced COTR

- OTR foil screens unusable for beam size measurement downstream of BC at LCLS
- $10^5$  intensity enhancement
- With large variations

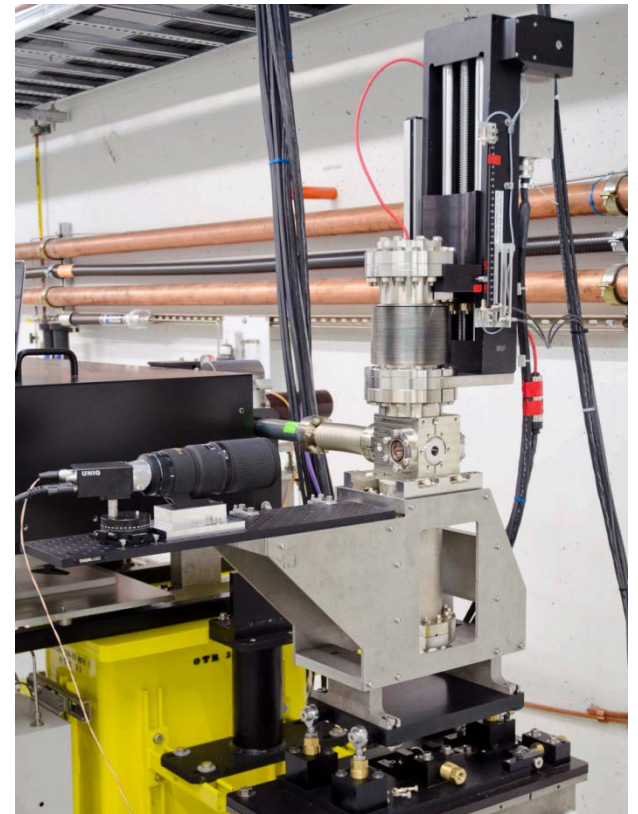


- Resorted to wire scanners for beam profiling
- Motivated to study COTR suppression with fluorescent screens

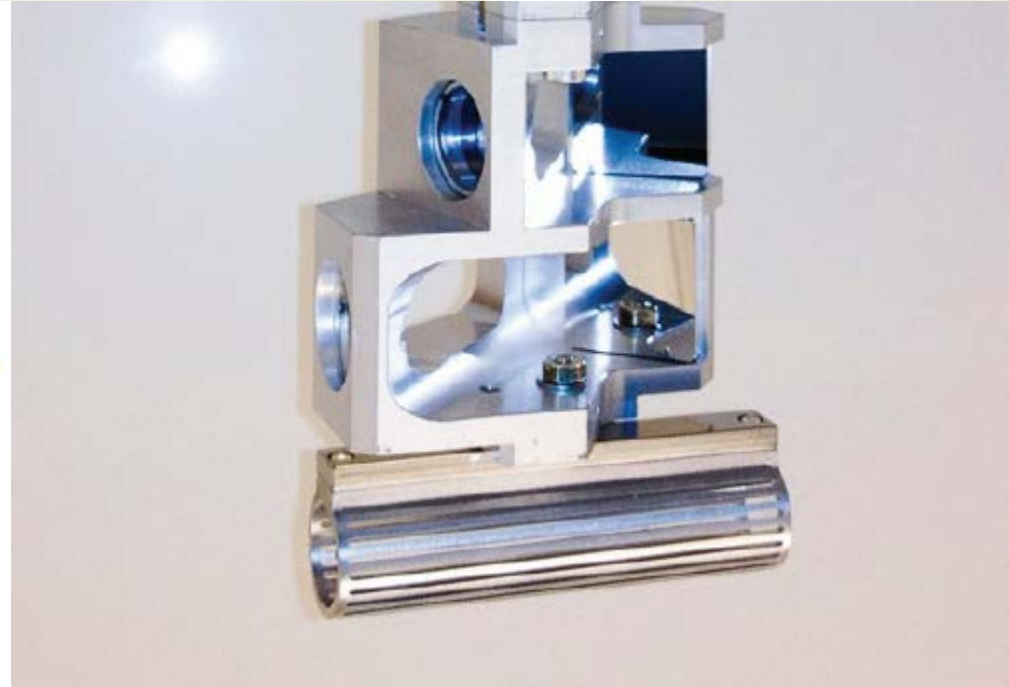
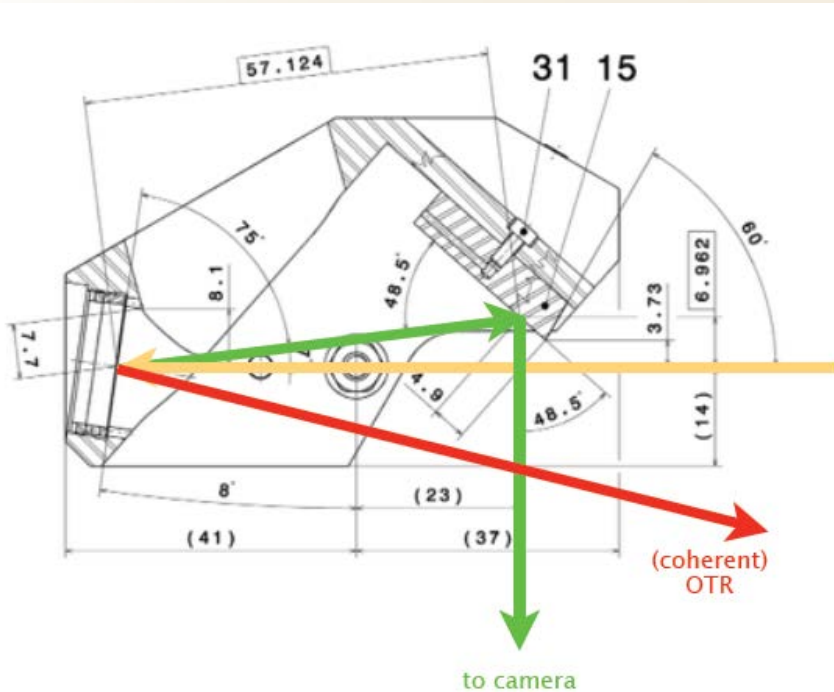


# PSI Profile Monitor Tests at LCLS

- YAG screen monitor designed by Rasmus Ischebeck built at PSI was installed in the LCLS LTU beamline
- 30 micron thick crystal
- Beam loss is still significant
- Max rep rate of 10 Hz
- Undulator stopper must be in



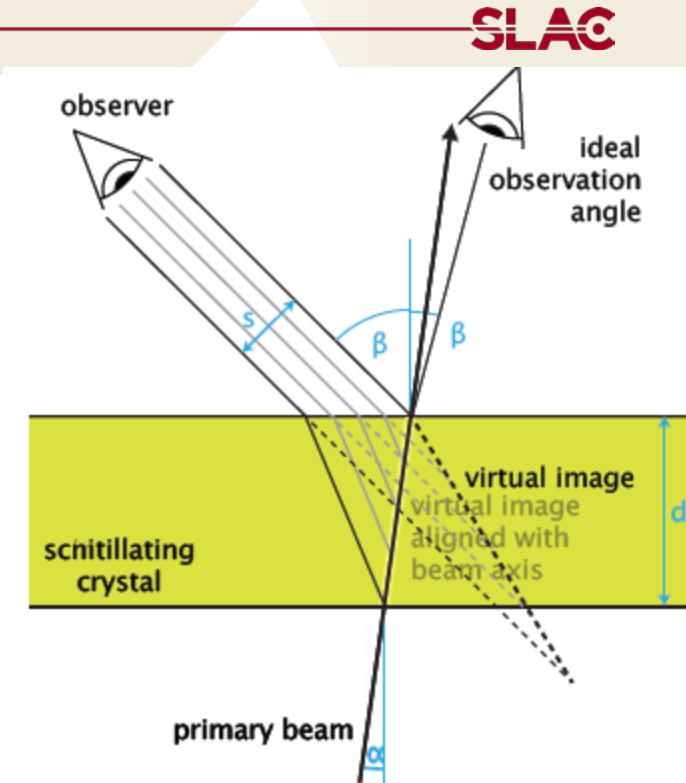
# Unique target geometry – R. Ischebeck



- COTR light is directed away from camera
- Requires use of Scheimpflug optics and Snell observation angle

## Unique target geometry – R. Ischebeck

- Observe the screen at the correct angle for Snells law so that beam sizes smaller than the screen thickness are imaged
- Camera image plane is also tilted to preserve depth of field across tilted crystal (Scheimpflug optics)



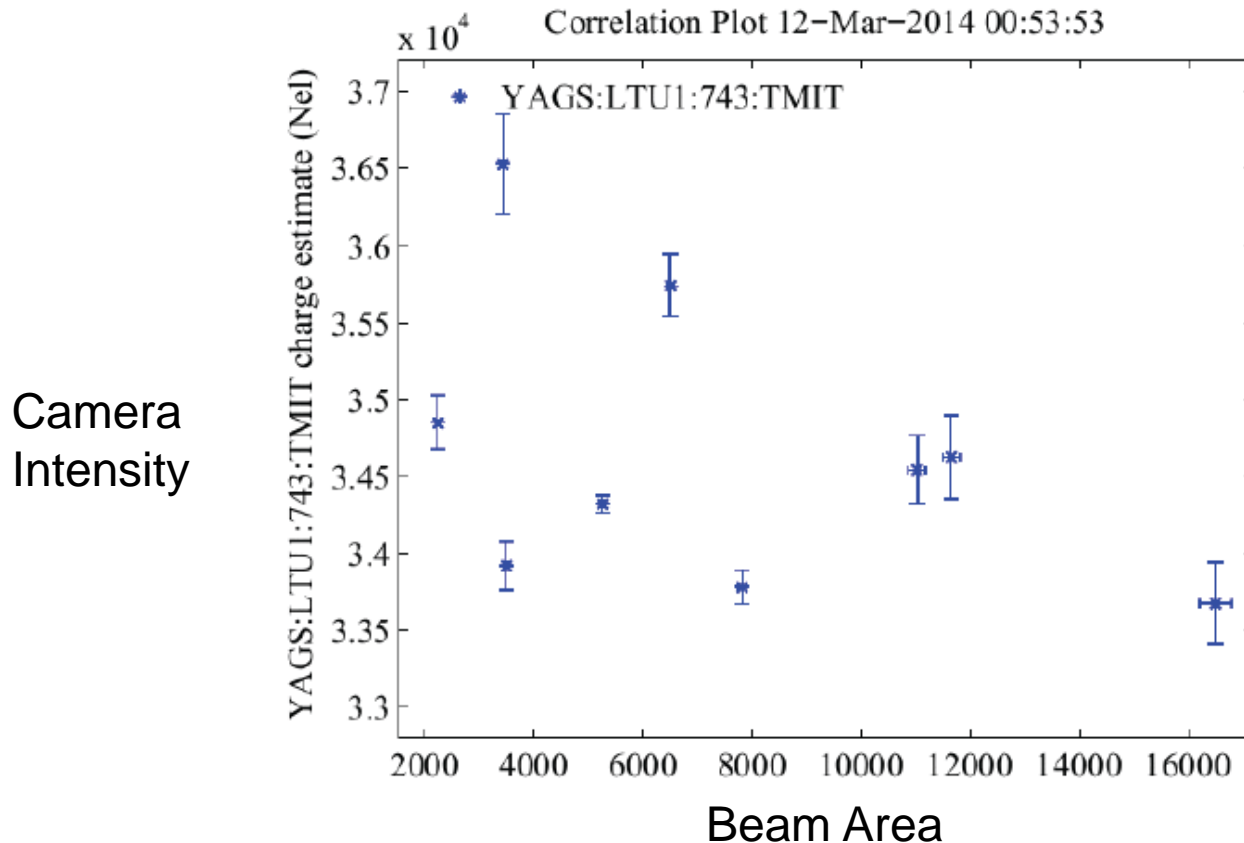
## Beam tests at LCLS (together with M. Yan, DESY)

- Concern is that screen may still be illuminated by upstream COTR
- And, that COTR may be short enough wavelength to fluoresce in the YAG crystal
- Measure image intensity as a function of:
  - Beam size
  - Bunch charge
  - Peak current (bunch length)
  - Laser heater power

# Screen intensity during beam size scan almost constant

Plot camera intensity vs beam area  $\sigma_x * \sigma_y$

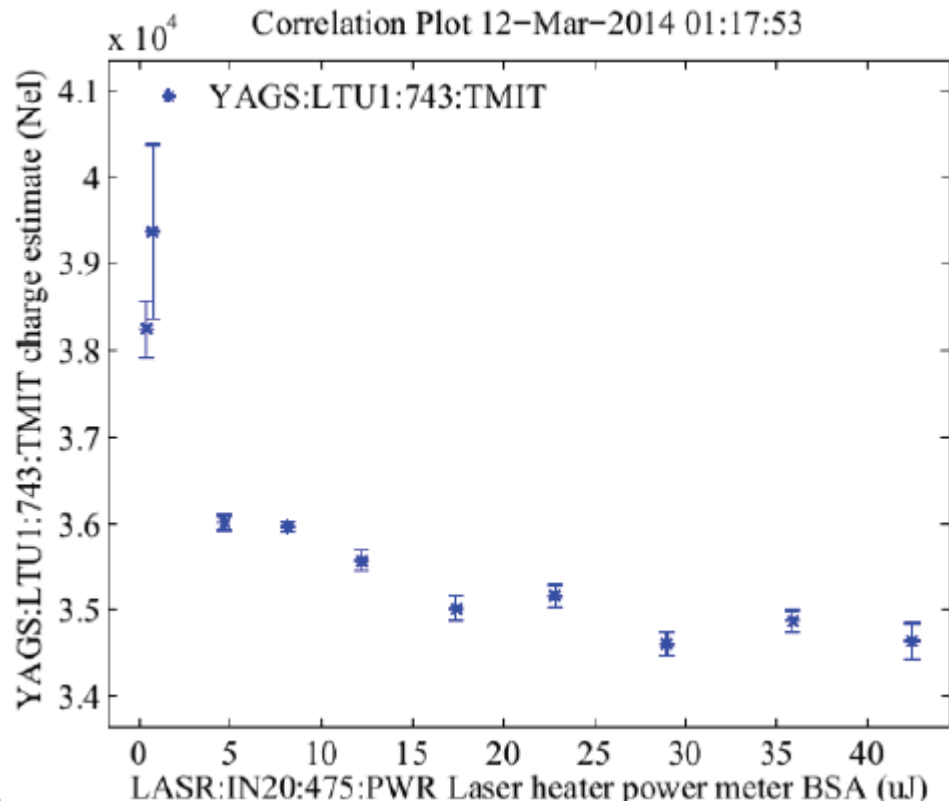
Laser heater ON; Nominal under compression



# Screen intensity versus laser heater power

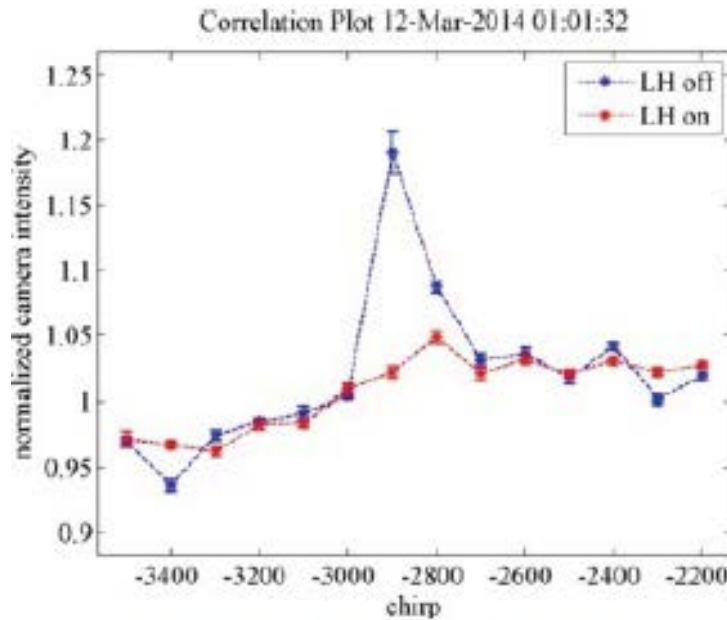
Fixed spot size

10% light intensity increase with laser heater OFF

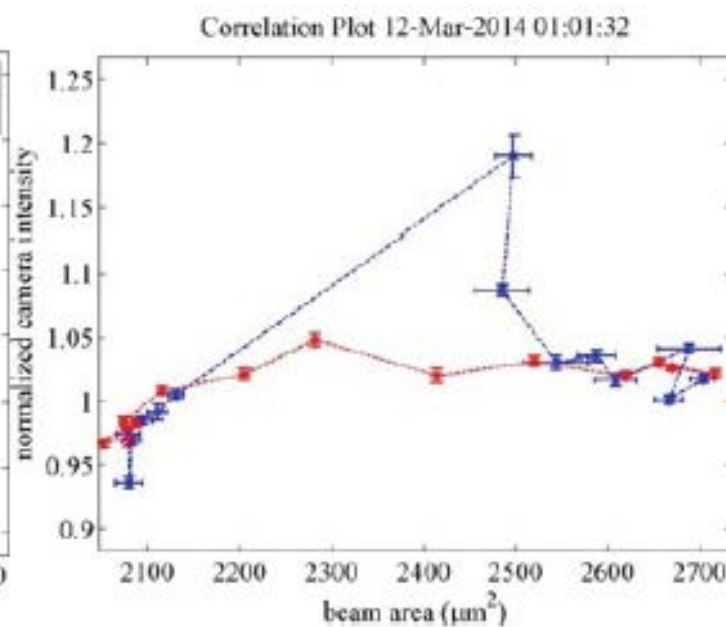


# Bunch length scan

20 pC bunch charge at 13.1 GeV  
Compare Laser Heater On/Off  
Worst case, factor 1.2 enhancement



Normalized to mean(Icamera)



Normalized to mean(Icamera)

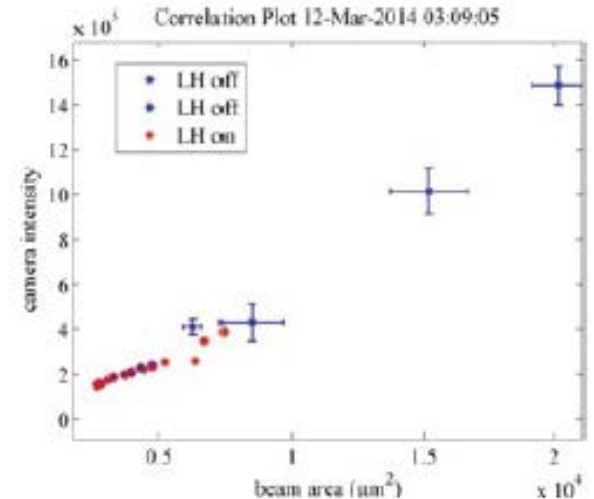
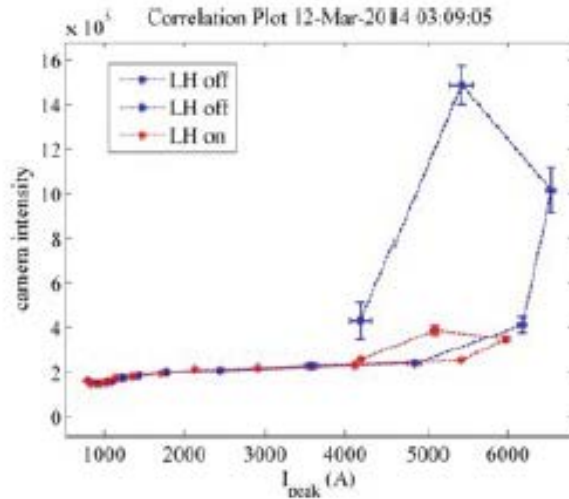
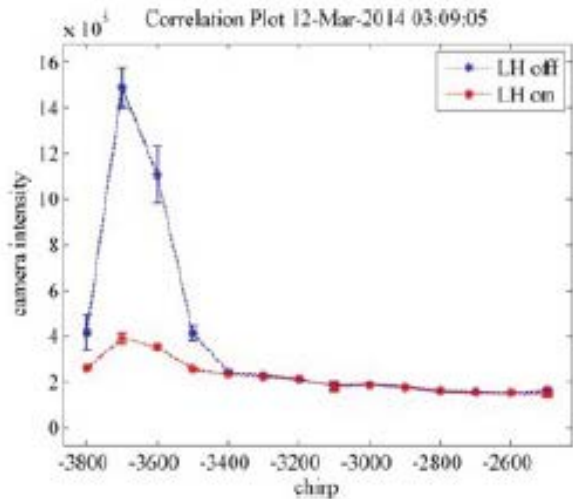
Analysis Minjie Yan

# Bunch length scan

150 pC bunch charge at 13.1 GeV

Compare Laser Heater On/Off

Worst case, factor 2 - 7 enhancement



Analysis Minjie Yan



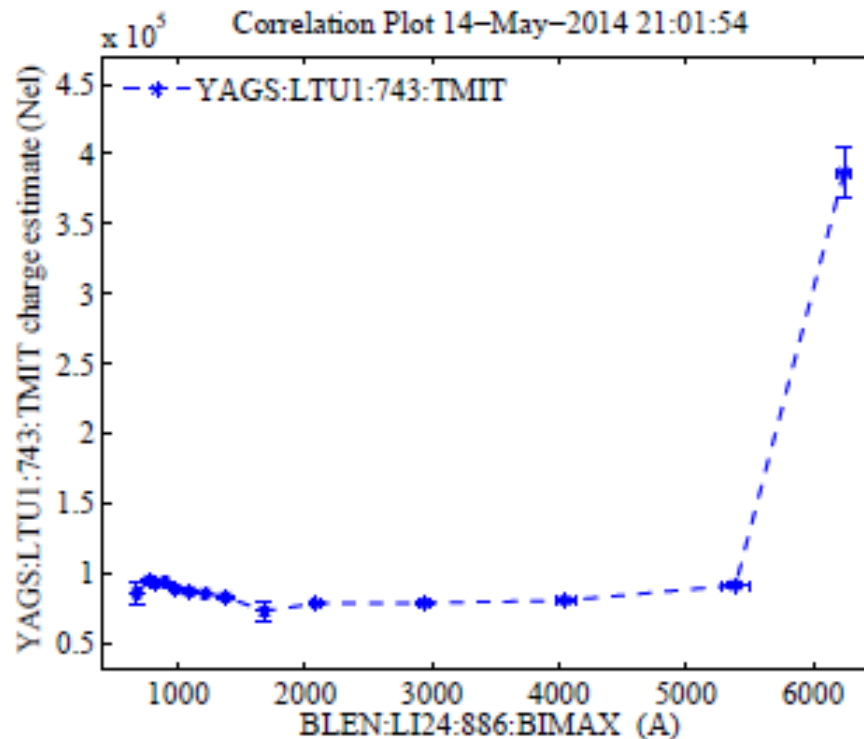
## More recent result

Add a narrow band yellow filter to the camera

150 pC bunch charge at 13.1 GeV

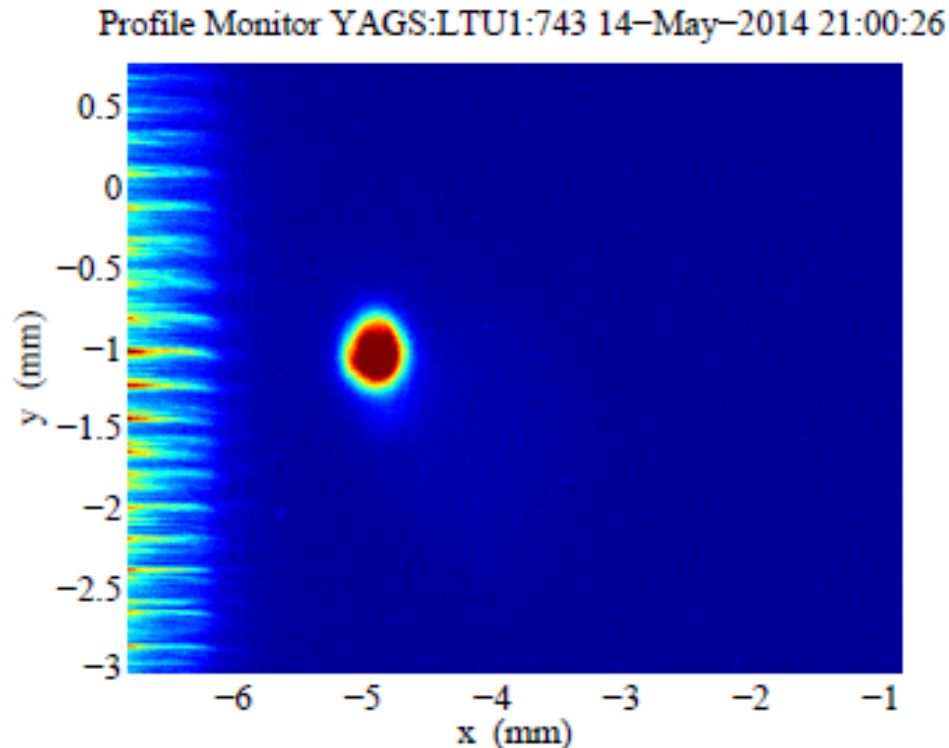
Compare Laser Heater Off

Worst case, factor 4 enhancement



## CDR visible on the edge of the screen

In the peak compression case, with LH off, we see coherent diffraction radiation at the edge of the screen (Probably generated from the edge of the mirror)



## Summary (2)

- The PSI design effectively suppresses COTR
- Can be used for single shot transverse beam size measurements
- Only in the worst cases (6 kA) of beam operation in the LCLS when the laser heater is off do we see factor  $\sim 4$  light intensity enhancement
- But, this has been reduced from  $10^5$  enhancement!

*Thank you!*